TOSHIBA Field Effect Transistor Silicon P Channel MOS Type ($L^2-\pi$ -MOSV)

2SJ512

Chopper Regulator, DC-DC Converter and Motor Drive Applications

• Low drain-source ON resistance : R_{DS} (ON) = 1.0 Ω (typ.)

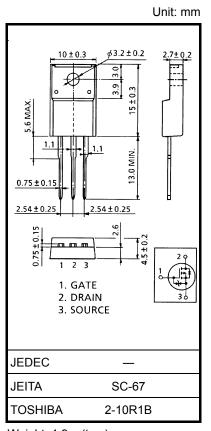
• High forward transfer admittance : $|Y_{fs}| = 3.7 \text{ S (typ.)}$

• Low leakage current $: I_{DSS} = -100 \mu A \text{ (max) (V}_{DS} = -250 \text{ V)}$

• Enhancement mode : $V_{th} = -1.5 \sim -3.5 \text{ V (V}_{DS} = -10 \text{ V, I}_{D} = -1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	-250	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	-250	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	ΙD	-5	Α	
	Pulse (Note 1)	I _{DP}	-20	Α	
Drain power dissipation	n (Tc = 25°C)	P_{D}	30	W	
Single pulse avalanche energy (Note 2)		E _{AS}	155	mJ	
Avalanche current		I _{AR}	-5	Α	
Repetitive avalenche energy (Note 3)		E _{AR}	3.0	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	



Weight: 1.9 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	4.16	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	62.5	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: V_{DD} = -50 V, T_{ch} = 25°C (initial), L = 10.5 mH, R_G = 25 Ω , I_{AR} = -5 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device.

Please handle with caution.



Electrical Characteristics (Ta = 25°C)

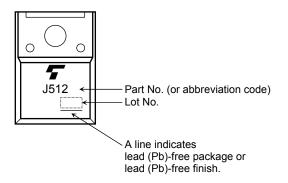
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = -250 V, V _{GS} = 0 V	_	_	-100	μΑ
Drain-source br voltage	reakdown	V (BR) DSS	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-250	_	_	V
Gate threshold v	/oltage	V _{th}	$V_{DS} = -10 \text{ V}, I_D = -1 \text{ mA}$	-1.5	_	-3.5	V
Drain-source O	N resistance	R _{DS (ON)}	$V_{GS} = -10 \text{ V}, I_D = -2.5 \text{ A}$	_	1.0	1.25	Ω
Forward transfer	r admittance	Y _{fs}	$V_{DS} = -10 \text{ V}, I_D = -2.5 \text{ A}$	1.8	3.7	_	S
Input capacitano	ce	C _{iss}		_	800	_	
Reverse transfer capacitance		C _{rss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	80	_	pF
Output capacitance		Coss		_	250	_	
Switching time	Rise time	t _r	V_{GS}^{OV} V_{CS}^{OV} V_{CS}^{OV} V_{CS}^{OV} $V_{DD}^{=}$ V_{DD}^{-100V}	_	16	_	
	Turn-on time	ton		_	35	_	
	Fall time	t _f		_	9	_	ns
	Turn-off time	t _{off}	Duty $\leq 1\%$, $t_{\mathbf{W}} = 10 \mu s$	_	70	_	
Total gate charge (Gate-source plus gate-drain)		Qg	$V_{DD} \approx -200 \text{ V, V}_{GS} = -10 \text{ V,}$ $I_{D} = -5 \text{ A}$	_	22		
Gate-source charge		Q _{gs}		_	14	_	nC
Gate-drain ("miller") charge		Q _{gd}		_	8	_	

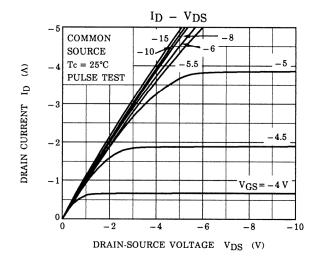
Source-Drain Ratings and Characteristics (Ta = 25°C)

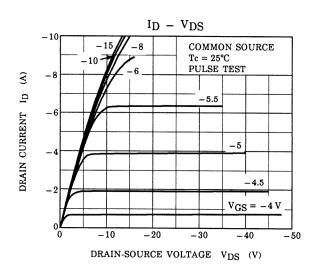
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	-5	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	-20	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = -5 A, V _{GS} = 0 V	_	_	2.0	V
Reverse recovery time	t _{rr}	I _{DR} = -5 A, V _{GS} = 0 V		205	_	ns
Reverse recovery charge	Q _{rr}	dI _{DR} / dt = 100 A / μs	_	2.1	_	μC

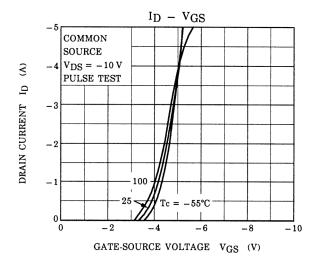
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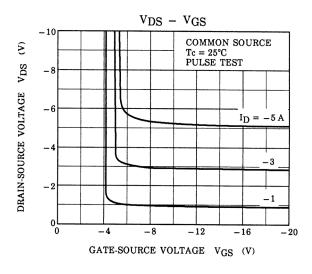
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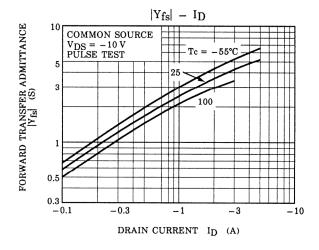


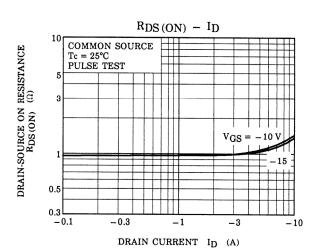




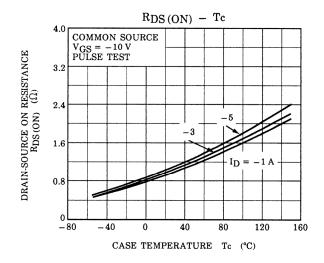


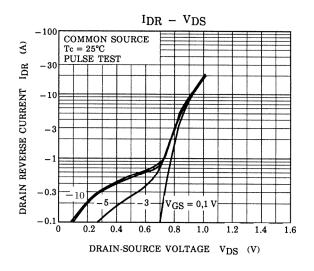


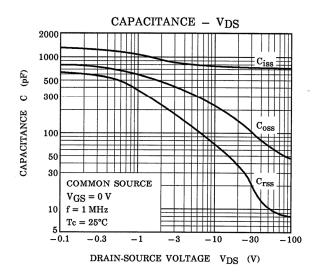


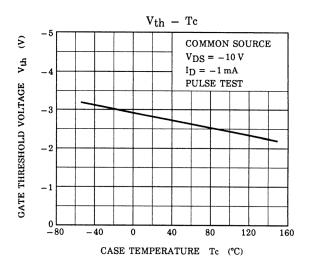


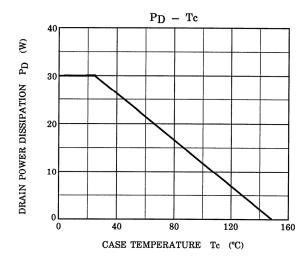
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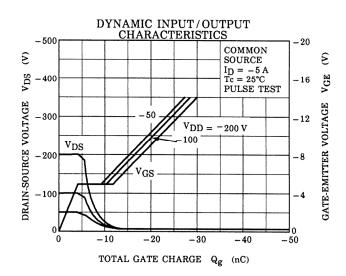


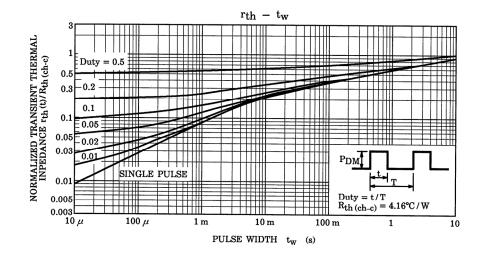


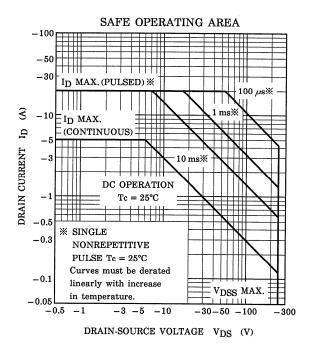


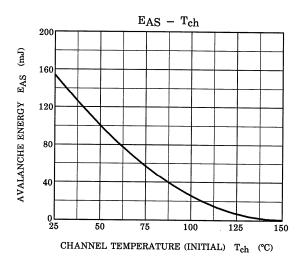


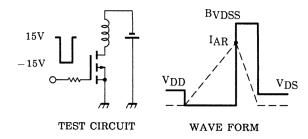












$$\begin{array}{ll} R_{\text{G}}\!=\!25\Omega \\ V_{\text{DD}}\!=\!-50\text{V}, \; L\!=\!10.5\text{mH} \end{array} \quad E_{\text{AS}}\!=\!\frac{1}{2}\cdot L\cdot I^2\cdot (\frac{B_{\text{VDSS}}}{B_{\text{VDSS}}\!-V_{\text{DD}}})$$

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